

Notice of References Cited	Application/Control No. 10/637,215		Applicant(s)/Patent Under Reexamination WEISS ET AL.	
	Examiner David A. Rogers		Art Unit 2856	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,701,178	12-1997	Burns et al.	356/600
*	C	US-6,217,272	04-2001	Felsenthal et al.	414/217
*	D	US-6,281,655	08-2001	Poon et al.	318/649
*	E	US-6,486,941	11-2002	Hazelton et al.	355/72
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*	H	US-2004/0086166	05-2004	Weiss et al.	382/141
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Arraychecker 3000" to PhotonDynamics, available on the Internet at < http://www.photondynamics.com >.
	V	"Arraychecker 3500" to PhotonDynamics, available on the Internet at < http://www.photondynamics.com >.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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